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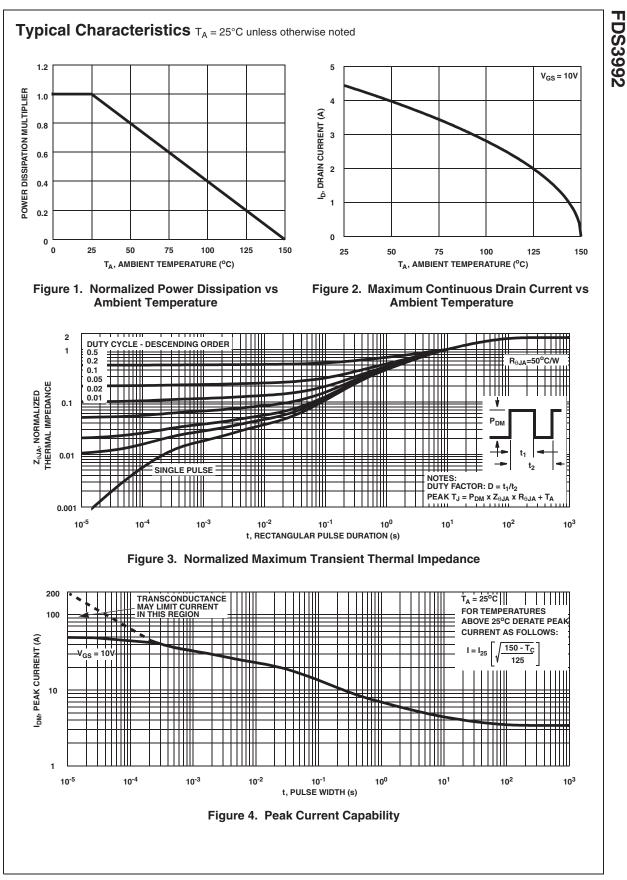
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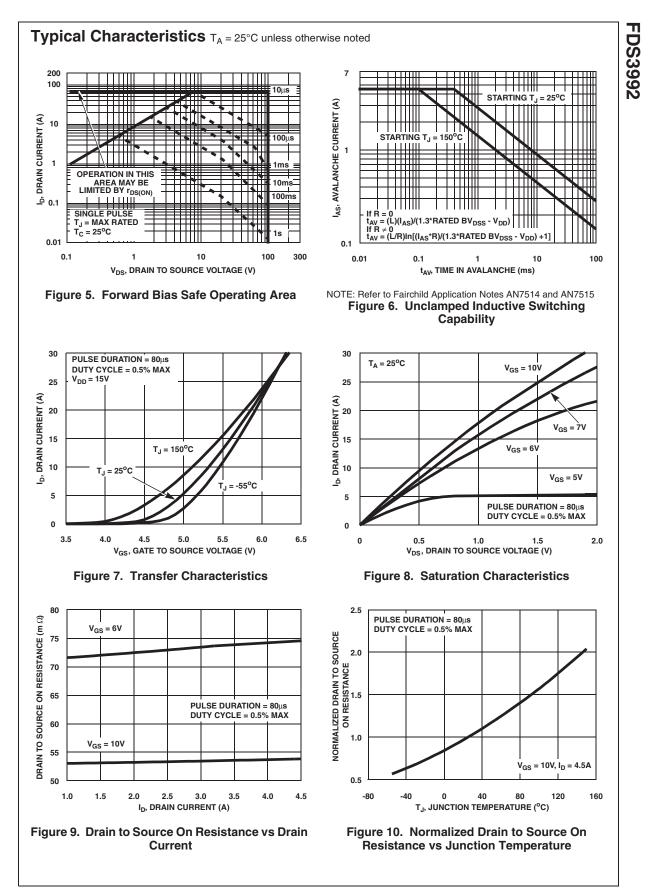
				April 2013				
Dual N-		PowerTrench	® MOSEET					
	.5A, 62m		MOOLET					
eatures	- , -		A	oplications				
			-	DC/DC converters and Off-Line UPS				
$r_{DS(ON)} = 54m\Omega$ (Typ.), $V_{GS} = 10V$, $I_D = 4.5A$								
 Q_g(tot) = 11nC (Typ.), V_{GS} = 10V Low Miller Charge 			•	Distributed Power Architectures and VRMs				
			•	Primary Switch for 24V and 48V Systems				
	Body Diode		•	High Voltage Sync	hronous Rectifier			
	-	t high frequencies				ame		
UIS Capa	bility (Single	Pulse and Repetitive P	uise)	Direct Injection / Diesel Injection Systems				
			•	42V Automotive Load Control				
Formerly deve	elopmental type	82745	•	Electronic Valve Train Systems				
	1 2 3 4 S	5 O-8				I I I I I I I I I		
		O-8 num Ratings ⊤ _A		erwise noted		(5)		
Symbol	T Maxim	O-8 num Ratings ⊤ _A Par	= 25°C unless oth ameter	erwise noted				
Symbol V _{DSS}	T Maxim	O-8 num Ratings ⊤ _A		erwise noted	(4) Charles (4) Ch	Units		
Symbol V _{DSS}	T Maxim	O-8 num Ratings T _A Par ource Voltage ource Voltage		erwise noted	(4) • • • • • • • • • • • • • • • • • • •	Units		
Symbol V _{DSS} V _{GS}	T Maxim Drain to So Gate to So Drain Curr Continuou	0-8 num Ratings T_A Par purce Voltage purce Voltage ent s (T_A = 25°C, V_GS = 10	v, R _{θJA} = 50°C/W)		(4) • • • • • • • • • • • • • • • • • • •	Units UV A		
Symbol V _{DSS} V _{GS}	T Maxim Drain to So Gate to So Drain Curr Continuou Continuou	O-8 num Ratings T _A Par ource Voltage ource Voltage ent	v, R _{θJA} = 50°C/W)		(4) • • • • • • • • • • • • • • • • • • •	Units Units V V A A A		
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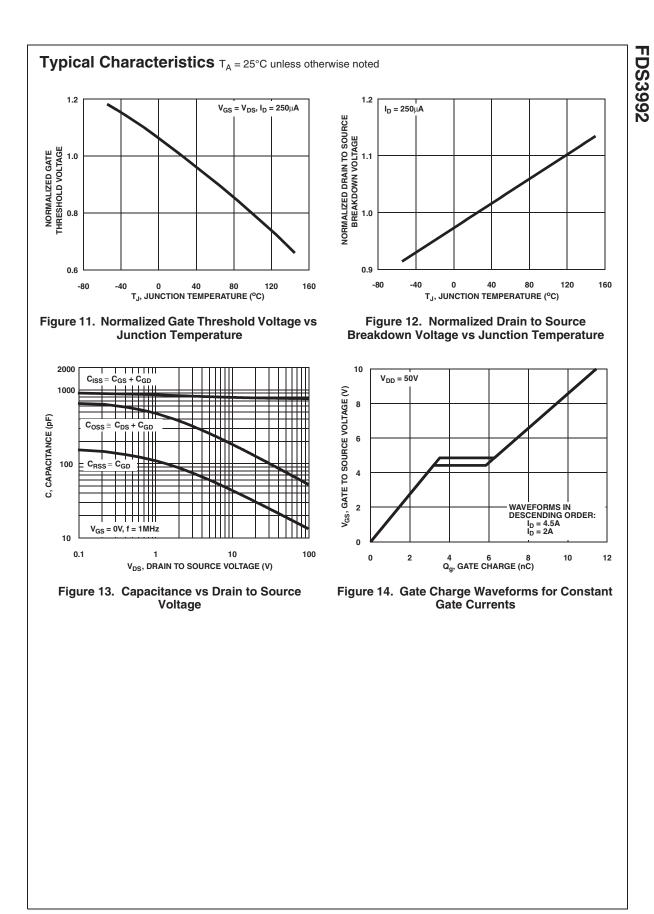
Symbol	Parameter	Parameter Test Conditions		Min	Тур	Max	Unit
Off Chara	cteristics						
B _{VDSS}	Drain to Source Breakdown Voltage	I _D = 250μA, V _{GS}	= 0V	100	-	-	V
-		$V_{DS} = 80V$		-	-	1	
IDSS	Zero Gate Voltage Drain Current	$V_{GS} = 0V$	$T_{C} = 150^{\circ}C$	-	-	250	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V$		-	-	±100	nA
On Chara	cteristics						
V _{GS(TH)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250µA		2	-	4	V
		$I_{\rm D} = 4.5 {\rm A}, V_{\rm GS} = 10 {\rm V}$		-	0.054	0.062	Ω
	Drain to Source On Begistenes	$I_{\rm D} = 2A, V_{\rm GS} = 6$	-	0.072	0.108		
rds(ON)	Drain to Source On Resistance	Drain to Source On Resistance $I_D = 4.5A, V_{GS} = 0.0$ $I_D = 4.5A, V_{GS} = 10V,$ $T_C = 150^{\circ}C$		-	0.107	0.123	
Dynamic	Characteristics						
C _{ISS}	Input Capacitance	V _{DS} = 25V, V _{GS} = 0V, f = 1MHz		-	750	-	pF
C _{OSS}	Output Capacitance			-	118	-	pF
C _{RSS}	Reverse Transfer Capacitance			-	27	-	pF
Q _{g(TOT)}	Total Gate Charge at 10V	V _{GS} = 0V to 10V	'	-	11	15	nC
Q _{g(TH)}	Threshold Gate Charge	$V_{GS} = 0V$ to 2V	V _{DD} = 50V	-	1.4	1.9	nC
Q _{gs}	Gate to Source Gate Charge		I _D = 4.5A	-	3.5	-	nC
Q _{gs2}	Gate Charge Threshold to Plateau	I _g = 1.0mA		-	2.1	-	nC
Q _{gd}	Gate to Drain "Miller" Charge			-	2.8	-	nC
Switching	g Characteristics (V _{GS} = 10V)						
t _{ON}	Turn-On Time	$V_{DD} = 50V, I_D = 4.5A$ $V_{GS} = 10V, R_{GS} = 27\Omega$		-	-	47	ns
t _{d(ON)}	Turn-On Delay Time			-	8	-	ns
t _r	Rise Time			-	23	-	ns
t _{d(OFF)}	Turn-Off Delay Time			-	28	-	ns
t _f	Fall Time			-	26	-	ns
t _{OFF}	Turn-Off Time			-	-	81	ns
ວrain-Soເ	urce Diode Characteristics						
V	Source to Drain Diede Veltage	I _{SD} = 4.5A		-	-	1.25	V
V _{SD}	Source to Drain Diode Voltage	$I_{SD} = 2A$	-	-	1.0	V	
t _{rr}	Reverse Recovery Time	I_{SD} = 4.5A, d I_{SD} /	-	-	48	ns	
Q _{RR}	Reverse Recovery Charge	I _{SD} = 4.5A, dI _{SD} /dt= 100A/μs		-	-	65	nC

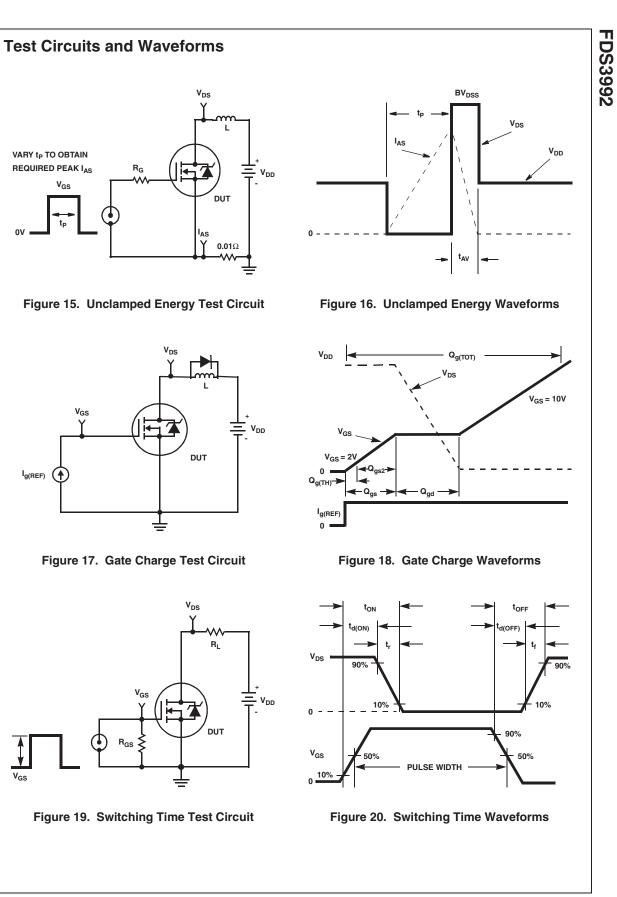
Notes:
1: E_{AS} of 167mJ is based on starting T_J = 25°C, L = 37mH, I_{AS} = 3A. 100% test at L = 1mH, I_{AS} = 10.3A.
2: R_{θJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{θJC} is guaranteed by design while R_{θCA} is determined by the user's board design.
3: R_{θJA} is measured with 1.0 in² copper on FR-4 board

FDS3992









Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature, $T_{JM}\!,$ and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, P_{DM} , in an Therefore the application's ambient application. temperature, T_A (°C), and thermal resistance $R_{\theta,JA}$ (°C/W) must be reviewed to ensure that T_{JM} is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}}$$
(EQ. 1)

In using surface mount devices such as the SO8 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of P_{DM} is complex and influenced by many factors:

- 1. Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
- 2. The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4. The use of thermal vias.

150

120

90

60

30 0

10-1

Z_{0JA}, THERMAL IMPEDANCE (°C/W)

- 5. Air flow and board orientation.
- 6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

Fairchild provides thermal information to assist the designer's preliminary application evaluation. Figure 21 defines the $R_{\theta,JA}$ for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the Fairchild device Spice thermal model or manually utilizing the normalized

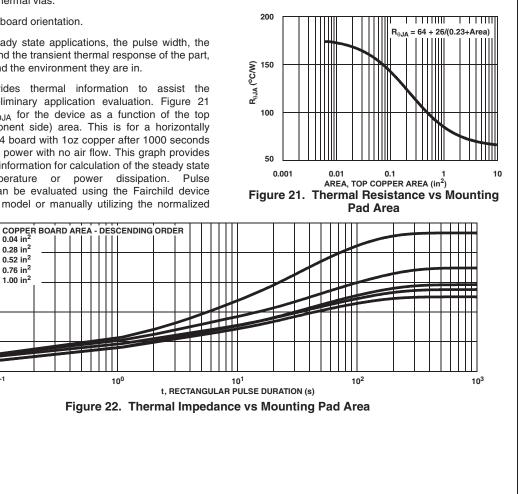
maximum transient thermal impedance curve.

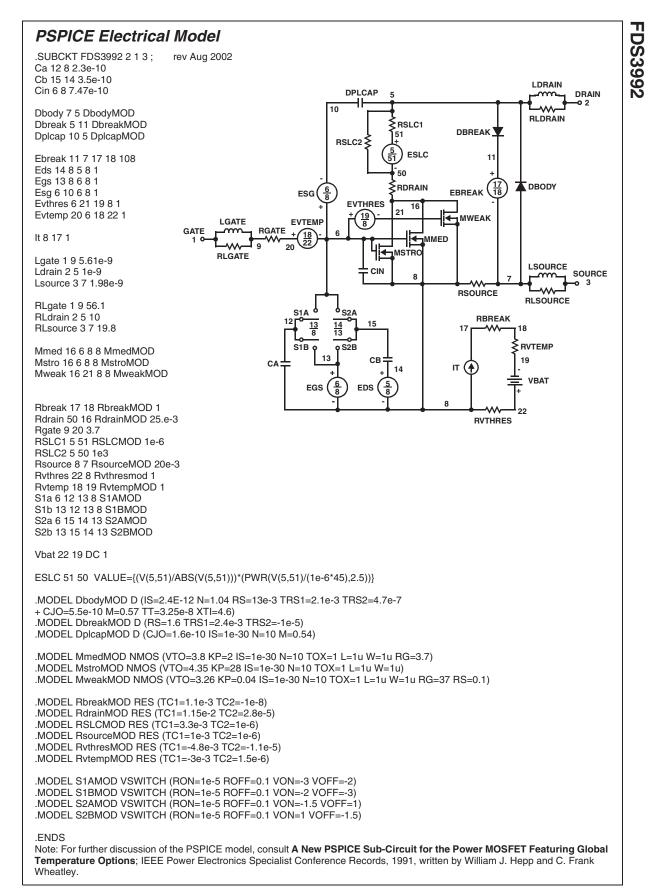
Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2. The area, in square inches is the top copper area including the gate and source pads.

$$R_{\theta JA} = 64 + \frac{26}{0.23 + Area}$$
 (EQ. 2)

The transient thermal impedance $(Z_{0,JA})$ is also effected by varied top copper board area. Figure 22 shows the effect of copper pad area on single pulse transient thermal impedance. Each trace represents a copper pad area in square inches corresponding to the descending list in the graph. Spice and SABER thermal models are provided for each of the listed pad areas.

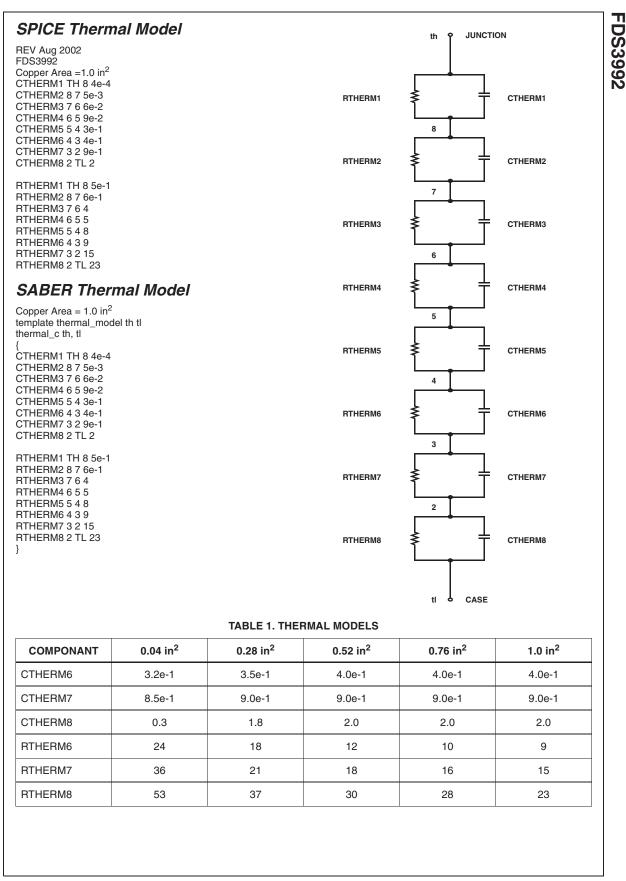
Copper pad area has no perceivable effect on transient thermal impedance for pulse widths less than 100ms. For pulse widths less than 100ms the transient thermal impedance is determined by the die and package. Therefore, CTHERM1 through CTHERM5 and RTHERM1 through RTHERM5 remain constant for each of the thermal models. A listing of the model component values is available in Table 1.





FDS3992

SABER Electrical Model REV Aug 2002 template FDS3992 n2,n1,n3 electrical n2,n1,n3 var i iscl dp..model dbodymod = (isl=2.4e-12,nl=1.04,rs=13e-3,trs1=2.1e-3,trs2=4.7e-7,cjo=5.5e-10,m=0.57,tt=3.25e-8,xti=4.6) dp..model dbreakmod = (rs=1.6,trs1=2.4e-3,trs2=-1.0e-5) dp..model dplcapmod = (cjo=1.6e-10,isl=10e-30,nl=10,m=0.54) m..model mmedmod = (type=_n,vto=3.8,kp=2.0,is=1e-30, tox=1) m..model mstrongmod = (type=_n,vto=4.35,kp=28,is=1e-30, tox=1) m..model mweakmod = (type=_n,vto=3.26,kp=0.04,is=1e-30, tox=1,rs=0.1) sw_vcsp..model s1amod = (ron=1e-5,roff=0.1,von=-3.0,voff=-2.0) LDRAIN sw_vcsp..model s1bmod = (ron=1e-5,roff=0.1,von=-2.0,voff=-3.0) DPLCAP DRAIN sw_vcsp..model s2amod = (ron=1e-5,roff=0.1,von=-1.5,voff=1.0) -11 -02 10 sw_vcsp..model s2bmod = (ron=1e-5,roff=0.1,von=1.0,voff=-1.5) **BLDBAIN** c.ca n12 n8 = 2.3e-10 ERSLC1 c.cb n15 n14 = 3.5e-10 51 BSLC2 ≥ c.cin n6 n8 = 7.47e-10 F) ISCL dp.dbody n7 n5 = model=dbodymod DBREAK 50 dp.dbreak n5 n11 = model=dbreakmod RDRAIN 6 8 dp.dplcap n10 n5 = model=dplcapmod ESG (11 DBODY EVTHRES 16 21 spe.ebreak n11 n7 n17 n18 = 108 19 8 4 MWEAK LGATE EVTEMP spe.eds n14 n8 n5 n8 = 1 GATE RGATE \sim 18 22 EBREAK spe.egs n13 n8 n6 n8 = 1 ٩ 20 spe.esg n6 n10 n6 n8 = 1 RLGATE spe.evthres n6 n21 n19 n8 = 1 LSOURCE spe.evtemp n20 n6 n18 n22 = 1 CIN SOURCE 8 3 o RSOURCE ~~~ i.it n8 n17 = 1 RLSOURCE S1A S2A l.lgate n1 n9 = 5.61e-9 RBREAK <u>13</u> 8 15 <u>14</u> 13 I.Idrain n2 n5 = 1e-917 18 l.lsource n3 n7 = 1.98e-9 ≤ RVTEMP o S2B S1B 13 СВ 19 res.rlgate n1 n9 = 56.1 CA IT 14 res.rldrain n2 n5 = 10 VBAT res.rlsource n3 n7 = 19.8 EGS 6 EDS 5 8 m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u 22 m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u RVTHRES m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u res.rbreak n17 n18 = 1, tc1=1.1e-3,tc2=-1e-8 res.rdrain n50 n16 = 25e-3, tc1=1.15e-2,tc2=2.8e-5 res.rgate n9 n20 = 3.7 res.rslc1 n5 n51 = 1e-6, tc1=3.3e-3,tc2=1e-6 res.rslc2 n5 n50 = 1e3 res.rsource n8 n7 = 20e-3, tc1=1e-3,tc2=1e-6 res.rvthres n22 n8 = 1, tc1=-4.8e-3,tc2=-1.1e-5 res.rvtemp n18 n19 = 1. tc1=-3e-3.tc2=1.5e-6 sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod v.vbat n22 n19 = dc=1 equations { i (n51->n50) +=iscl iscl: v(n51,n50) = ((v(n5,n51)/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6/45))**2.5)))}





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- A critical component in any component of a life support, device, or 2. system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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